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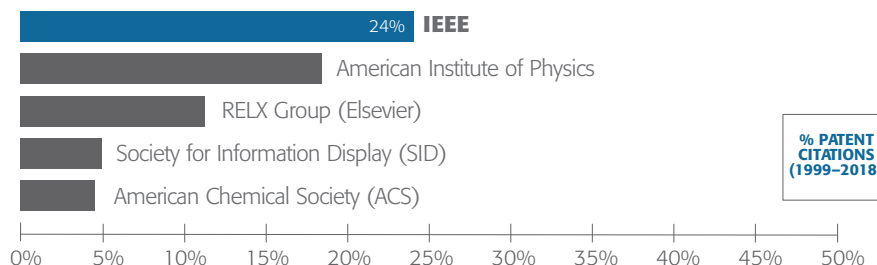
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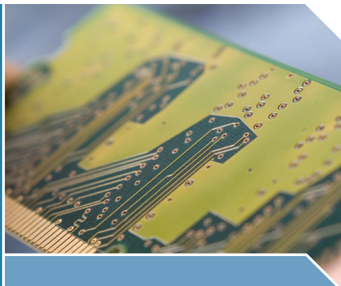
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### Conferences

- IEEE International Conference on Semiconductor Electronics
- IEEE International Semiconductor Laser Conference
- IEEE Semiconductor Thermal Measurement and Management Symposium
- IEEE Symposium on Compound Semiconductor Integrated Circuit
- IEEE Symposium on Semiconductor Thermal Measurement and Management
- IEEE/SEMI Conference and Workshop Advanced Semiconductor Manufacturing
- International Conference on Advanced Semiconductor Devices and Microsystems
- International Conference on Advanced Thermal Processing of Semiconductors
- International Conference on Semiconductor Laser and Photonics
- International Semiconductor Conference
- International Semiconductor Device Research Symposium
- International Symposium on Power Semiconductor Devices and ICs
- International Symposium on Semiconductor Device Research
- International Symposium on Semiconductor Manufacturing

### Standards

- |                            |  |
|----------------------------|--|
| 592-2007                   | IEEE Standard for Exposed Semiconducting Shields on High-Voltage Cable Joints and Separable Connectors   |
| 1450.1-2005                | IEEE Standard for Extensions to Standard Test Interface Language (STIL) (IEEE Std 1450 /SUP TM/ 1999) for Semiconductor Design Environments        |
| IEC 62526 edition 1.0 2007 | Standard for Extensions to Standard Test Interface Language (STIL) for Semiconductor Design Environments   |
| C57.18.10-1998             | IEEE Standard Practices and Requirements for Semiconductor Power Rectifier Transformers  |
| C62.35-2010                | IEEE Standard Test Methods for Avalanche Junction Semiconductor Surge-Protective Device Components   |
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